Use of a Lowest Intensity $^{241}$Am Compton Spectrometer for the Measurement of Directional Compton Profiles of ZnSe

Babu Lal Ahuja and Narayan Lal Heda

Department of Physics, University College of Science, M. L. Sukhadia University, Udaipur 313001, Rajasthan, India

Reprint requests to Dr. B. L. A.; E-mail: blahuja@yahoo.com

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In this paper we report on electron momentum densities in ZnSe using Compton scattering technique. For the directional measurements we have employed a newly developed 100 mCi $^{241}$Am Compton spectrometer which is based on a small disc source with shortest geometry. For the theoretical calculations we have employed a self-consistent Hartree-Fock linear combination of atomic orbitals (HF-LCAO) approach. It is seen that the anisotropy in the measured Compton profiles is well reproduced by our HF-LCAO calculation and the other available pseudopotential data. The anisotropy in the Compton profiles is explained in terms of energy bands and bond length. – PACS numbers: 13.60.Fz, 78.70. Ck, 78.70.-g

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